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(12) **United States Design Patent**
Wong et al.

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(54) **INFANT THERMOMETER**

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(**) Term: **14 Years**

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(22) Filed: **Apr. 21, 2003**

(51) **LOC (7) Cl.** **10-04**
(52) **U.S. Cl.** **D10/57**
(58) **Field of Search** D10/57; 374/5, 374/124, 151, 158, 163, 168, 208; 600/438, 474, 549

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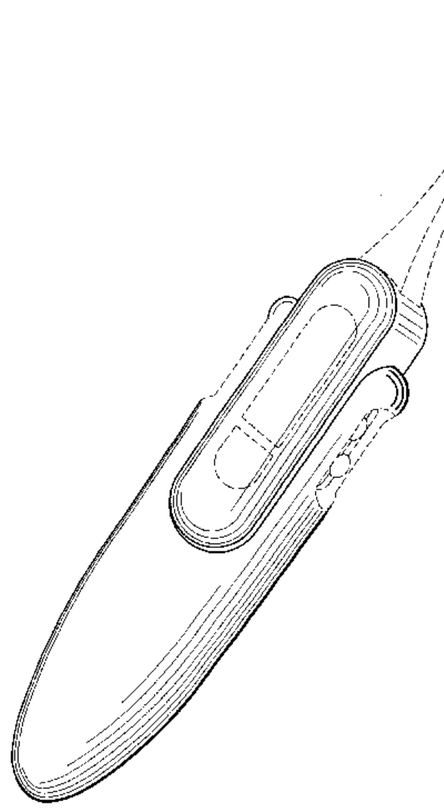
(57) **CLAIM**

The ornamental design for an infant thermometer, as shown and described.

DESCRIPTION

FIG. **1** is a perspective view of an infant thermometer in accordance with a first embodiment of our new design, with portions of the infant thermometer being illustrated in broken lines, which broken lines are for illustrative purposes only and form no part of the infant thermometer;
FIG. **2** is a front elevational view of the infant thermometer shown in FIG. **1**;
FIG. **3** is a rear elevational view of the infant thermometer thereof;
FIG. **4** is a right-side elevational view thereof;
FIG. **5** is a left-side elevational view thereof;
FIG. **6** is a top view thereof;
FIG. **7** is a bottom view thereof;
FIG. **8** is a perspective view of an infant thermometer in accordance with a second embodiment of our new design, with portions of the infant thermometer being illustrated in broken lines, which broken lines are for illustrative purposes only and form no part of the infant thermometer;
FIG. **9** is a front elevational view of the infant thermometer shown in FIG. **8**;
FIG. **10** is a right-side elevational view thereof; and,
FIG. **11** is a left-side elevational view thereof, and rear, top, and bottom views of the infant thermometer of the second embodiment are identical to the rear, top, and bottom views of the infant thermometer of the first embodiment shown in FIGS. **1–7**.

1 Claim, 6 Drawing Sheets



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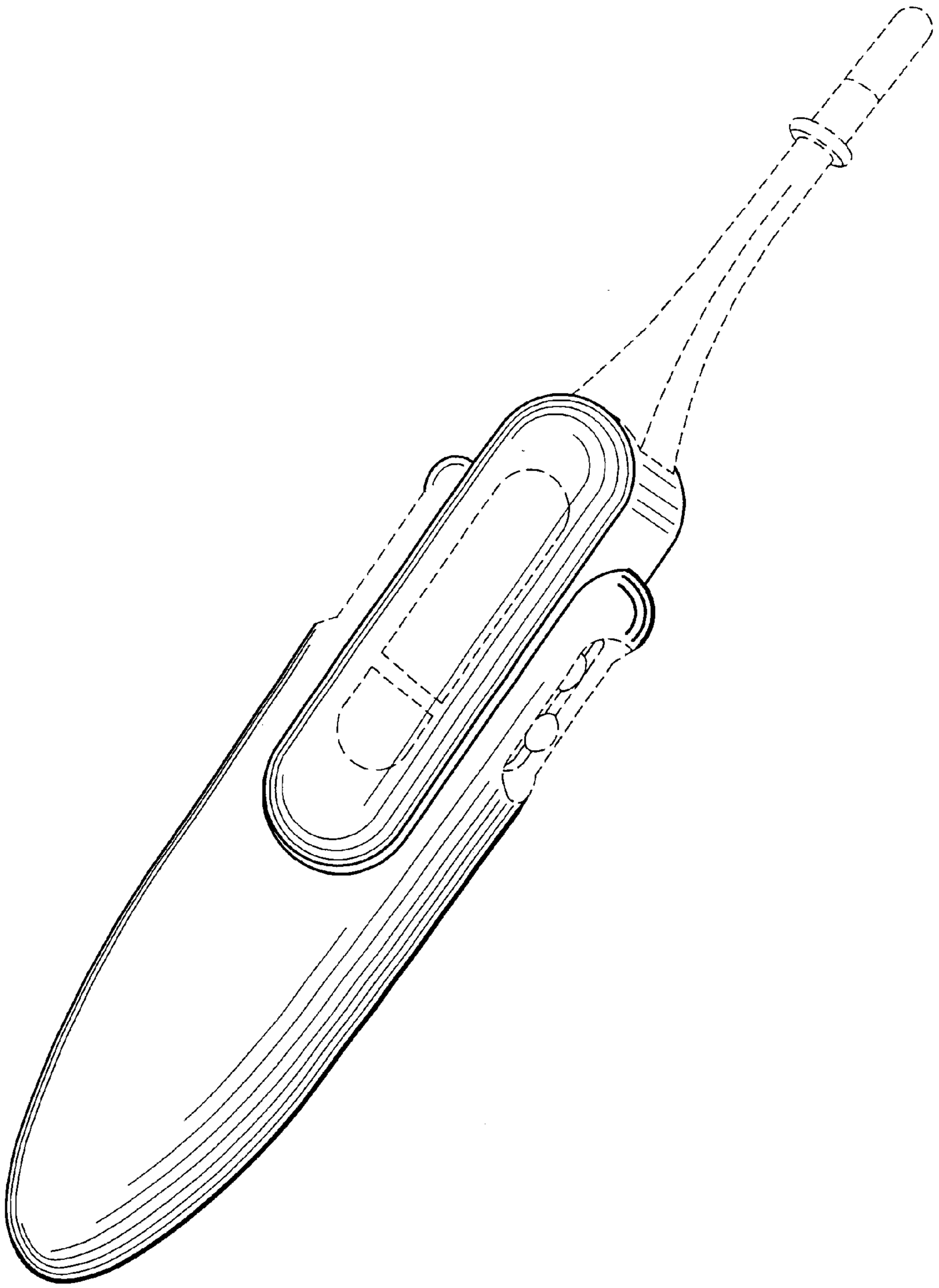

Fig. 1

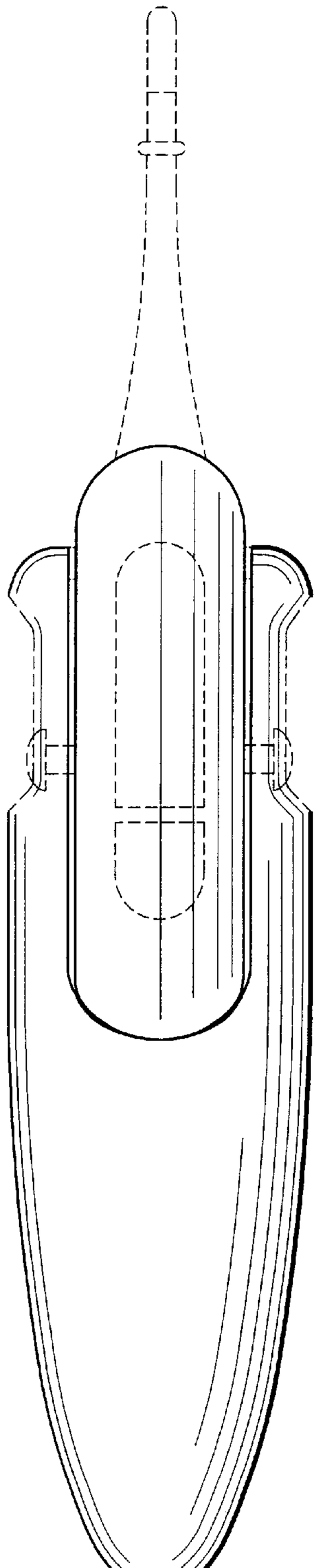

Fig. 2

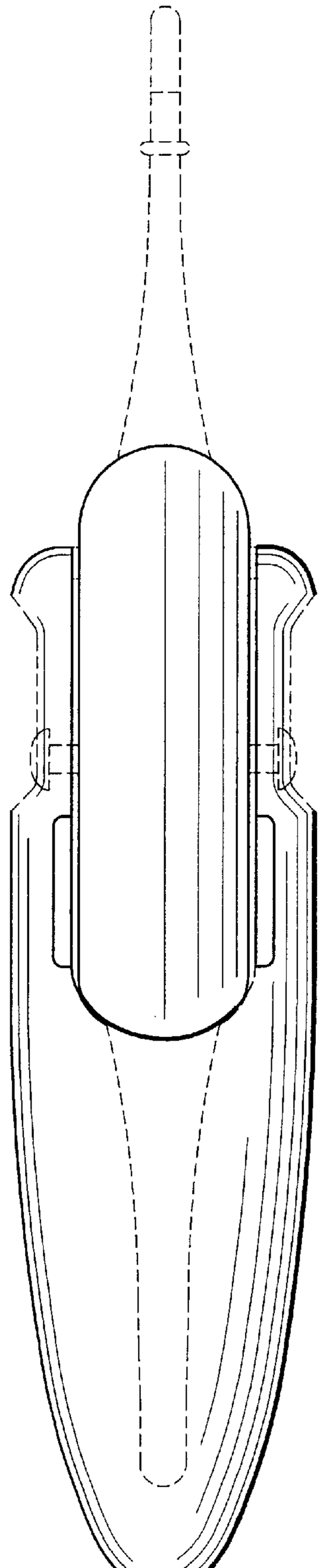

Fig. 3

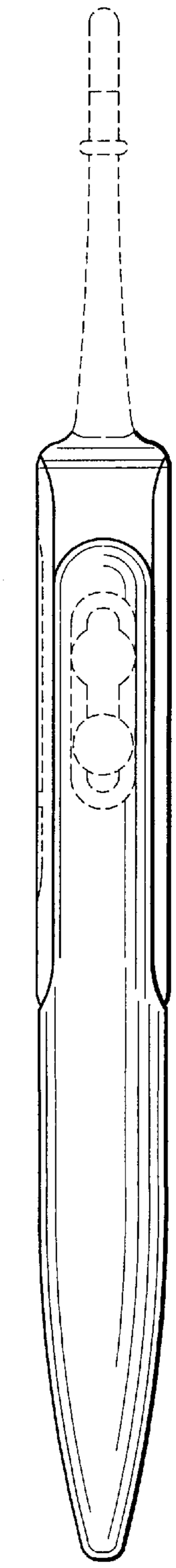

Fig. 4

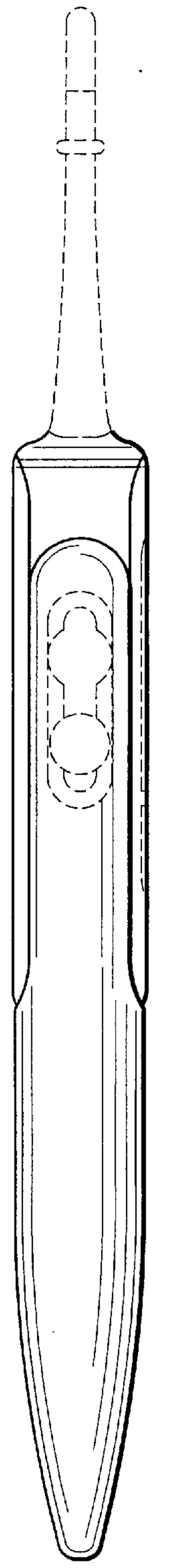

Fig. 5

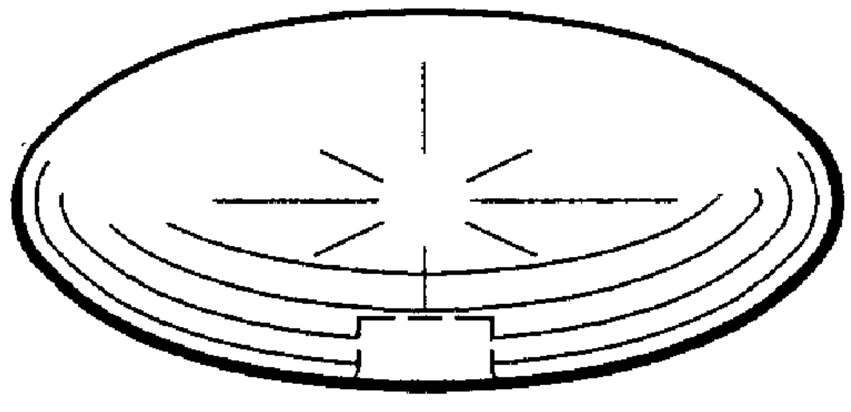

Fig. 6

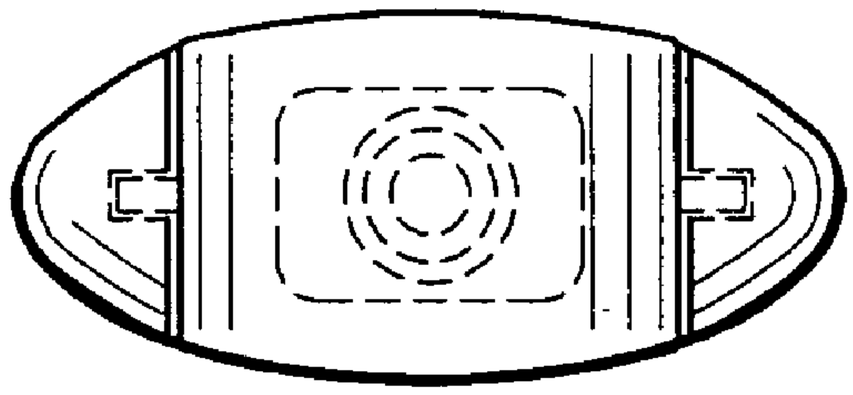

Fig. 7

Fig. 8

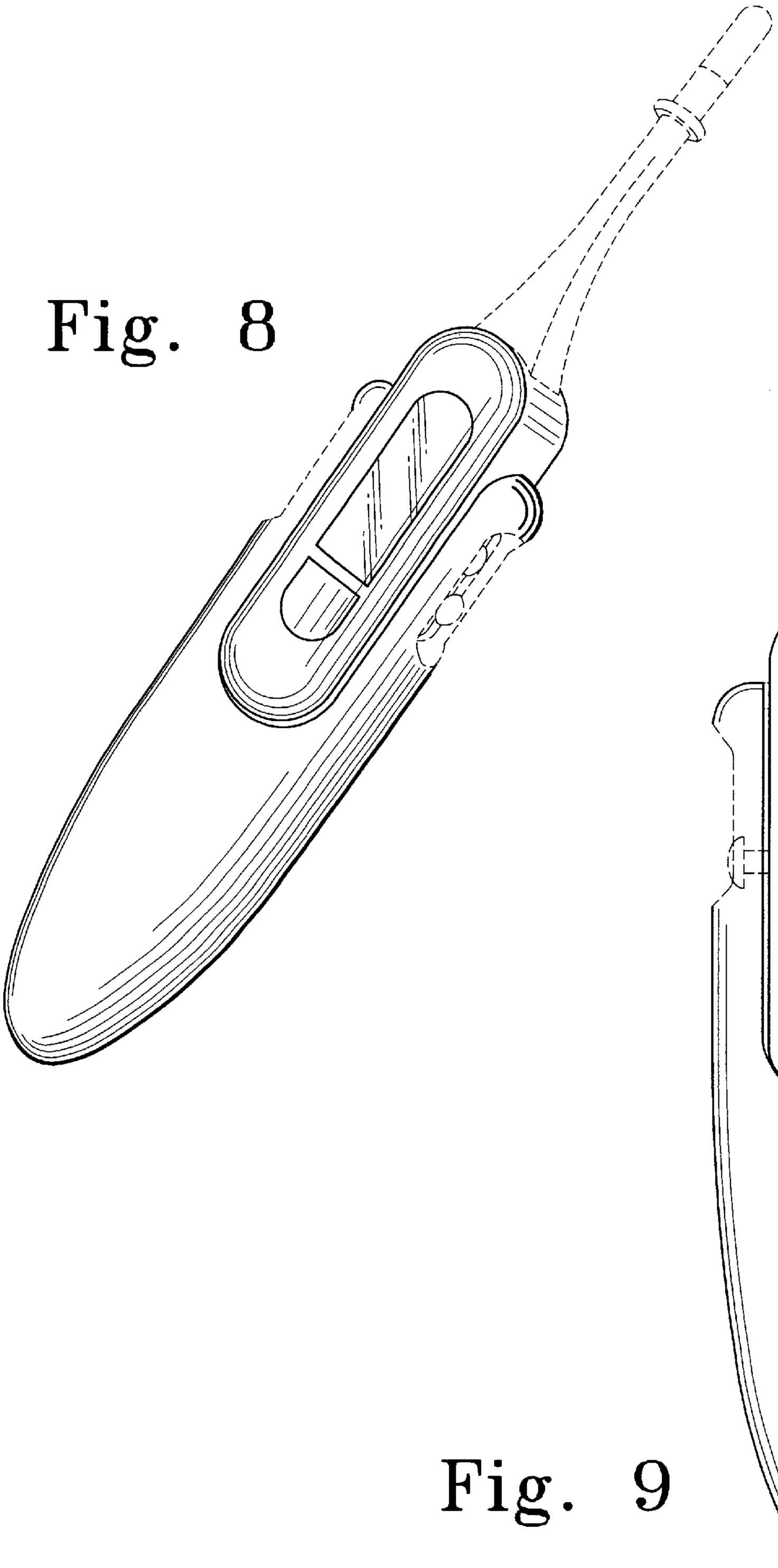

Fig. 9

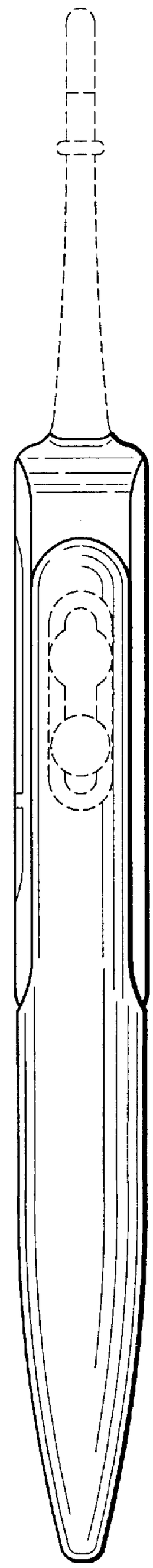

Fig. 10

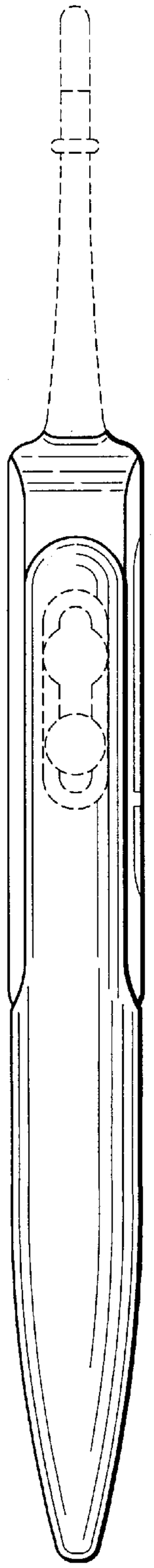

Fig. 11